

FORM PTO-1449 (SUBSTITUTE)		Attorney Docket No.: GR 98 P 8041	Serial No. 09/313,424
U.S. DEPARTMENT OF COMMERCE SEP - 1 1999 PATENT AND TRADEMARK OFFICE		Applicant Thomas Huttner et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))		Filing Date May 17, 1999	Group Art Unit 2811

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
BK	A	4,774,196	09/27/88	Blanchard			
BK	B	5,517,047	05/14/96	Linn et al.			
	C						
	D						
	E						
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	I						

FOREIGN PATENT DOCUMENT

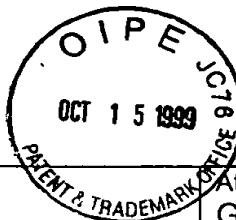
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES	NO
	J	197 49 345 A1	08/27/98	Germany				X
	K							
	L							
	M							
	N							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

BK	O	Japanese Patent Abstract No. 5-217822, dated August 29, 1993
BK	P	Stephan Pindl et al.: "Silicon-on-insulator-Technologie: Neue "Low-Power"-CMOS-Anwendungen mit betriebsspannungen kleiner 0,9 V", Phys. Bl. 54 (1998) Nr. 4, pp. 353-355, silicon-on-insulator-technology: new "low-power"-CMOS-applications with an operating voltage of less than 0.9 V.

EXAMINER	DATE CONSIDERED
Brook Kehede	September 21, 2000

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
BK	A	5,468,657	11/21/95	Hsu			
BK	B	5,596,218	01/21/97	Soleimani et al.			
	C						
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

BK	O	Japanese Patent Abstract No. 02054532 (Takefumi), dated February 23, 1990
BK	P	Japanese Patent Abstract No. 03149821 (Juri), dated June 26, 1991

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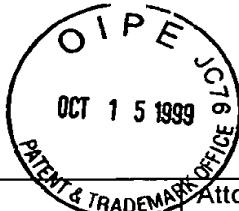
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>BSL</i>	O	Japanese Patent Abstract No. 05047726 (Shinichi), dated February 26, 1993
<i>BSL</i>	P	Japanese Patent Abstract No. 10163218 (Takashi), dated June 19, 1998

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>BU</i>	O	International Patent Application WO 99/17357 (Biebl), dated April 8, 1999
	P	

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